Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY DOCKET NO. 247973US2	SERIAL NO. 10/762,476
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Naoto SHIRAISHI	
		FILING DATE January 23, 2004	GROUP

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
A.C.	AA	2003/0063813	4/3/2003	Naoto SHIRAISHI; Appl. No. 10/127,553; Filed 4/23/2002	—	—	
A.C.	AB	2003/0053701	3/20/2003	Naoto SHIRAISHI; Appl No. 10/100,776; Filed 3/19/2002	—	—	
A.C.	AC	5,903,276	5/11/1999	Naoto SHIRAISHI	—	—	
A.C.	AD	5,828,378	10/27/1998	Naoto SHIRAISHI	—	—	
A.C.	AE	6,172,678	1/9/2001	Naoto SHIRAISHI	—	—	
A.C.	AF	5,732,204	3/24/1998	Masanobu FUKUSHIMA, et al.	—	—	
A.C.	AG	5,448,690	9/5/1995	Naoto SHIRAISHI, et al.	—	—	
A.C.	AH	5,551,019	8/27/1996	Yasuhiro IZAWA, et al.	—	—	
A.C.	AI	5,455,900	10/3/1995	Naoto SHIRAISHI, et al.	—	—	
A.C.	AJ	5,739,826	4/14/1998	Naoto SHIRAISHI, et al.	—	—	
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A.C.	AL	5,337,168	8/9/1994	Tatsuya FUJII, et al.	—	—	
A.C.	AM	5,465,371	11/7/1995	Tatsuya FUJII, et al.	—	—	
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A.C.	AO	5,341,468	8/23/1994	Naoto SHIRAISHI, et al.	—	—	
A.C.	AP	5,859,650	1/12/1999	Naoto SHIRAISHI	—	—	
A.C.	AQ	6,081,274	6/27/2000	Naoto SHIRAISHI	—	—	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	☐ Additional References sheet(s) attached

Examiner	Date Considered 3/4/05

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
A.C.	AO	11-99701	04/13/1999	JAPAN (with English Abstract)		X
A.C.	AP	9-190538	07/22/1997	JAPAN (with English Abstract)		X
A.C.	AQ	2001-101431	04/13/2001	JAPAN (with English Abstract)		X
A.C.	AR	11-15997	01/22/1999	JAPAN (with English Abstract)		X
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	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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	AX	
	AY	
	AZ	☐ Additional References sheet(s) attached

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